



**THE DATASHEET OF  
ESD105B102ELE6327XTMA1**



# TVS Diodes

Transient Voltage Suppressor Diodes

## ESD105-B1-02 Series

Low Capacitance & Low Clamping Bi-directional ESD / Transient Protection Diodes

ESD105-B1-02ELS  
ESD105-B1-02EL

## Data Sheet

Revision 1.0, 2013-12-12  
Final

**Revision History: Rev. 04, 2013-09-24**

Page or Item	Subjects (major changes since previous revision)
<b>Revision 1.0, 2013-12-12</b>	
All	Status change to Final

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Last Trademarks Update 2010-06-09

# 1 Low Capacitance & Low Clamping Bi-directional ESD / Transient Protection Diodes

## 1.1 Features

- ESD / Transient protection of signal lines exceeding standard:
  - IEC61000-4-2 (ESD):  $\pm 30$  kV air /  $\pm 25$  kV contact discharge
  - IEC61000-4-4 (EFT):  $\pm 50$  A (5/50 ns)
  - IEC61000-4-5 (Surge):  $\pm 5$  A (8/20  $\mu$ s)
- One-line diode with ultra-small form factor down to 0.62 x 0.32 x 0.31 mm<sup>2</sup> (0201) package size
- Bi-directional, symmetrical working voltage up to:  $V_{RWM} = \pm 5.5$  V
- Low capacitance  $C_L = 0.3$  pF (typical)
- Very low clamping voltage, low dynamic resistance:  $R_{DYN} = 0.36$   $\Omega$  (typ.)
- Pb-free package (RoHS compliant) and halogen free package



## 1.2 Application Examples

- USB 3.0, 10/100/1000 Ethernet, Firewire, DVI, HDMI, S-ATA, Display Ports
- Mobile HDMI Link, MDDI, MIPI, SWP, NFC

## 1.3 Product Description

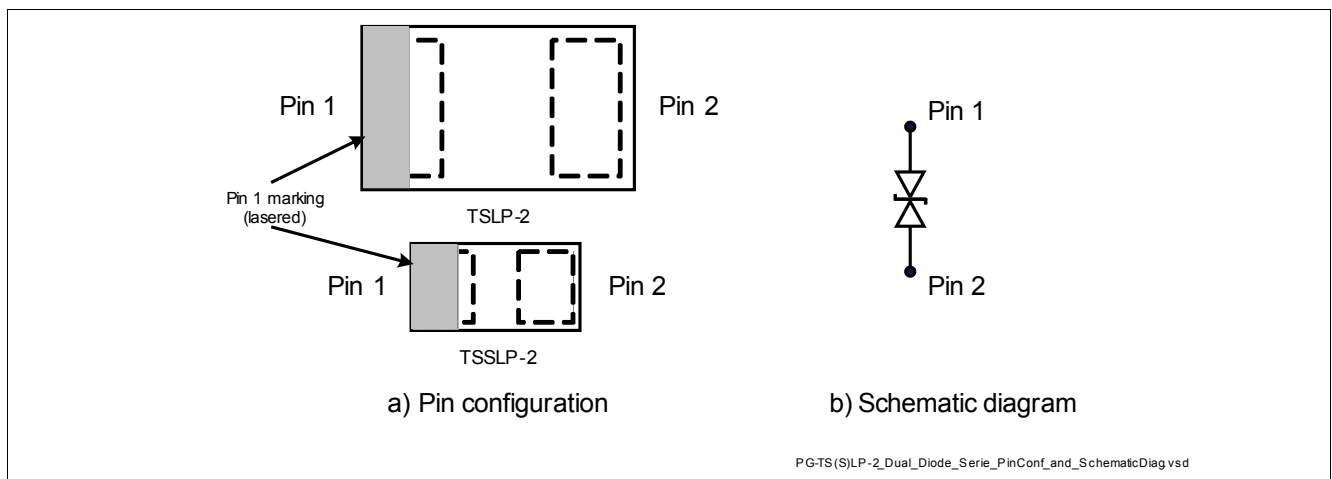


Figure 1 Pin configuration and Schematic diagram

Table 1 Ordering Information

Type	Package	Configuration	Marking code
ESD105-B1-02ELS	TSSLP-2-4	1 line, bi-directional	<u>N</u>
ESD105-B1-02EL	TSLP-2-20	1 line, bi-directional	N

## 2 Characteristics

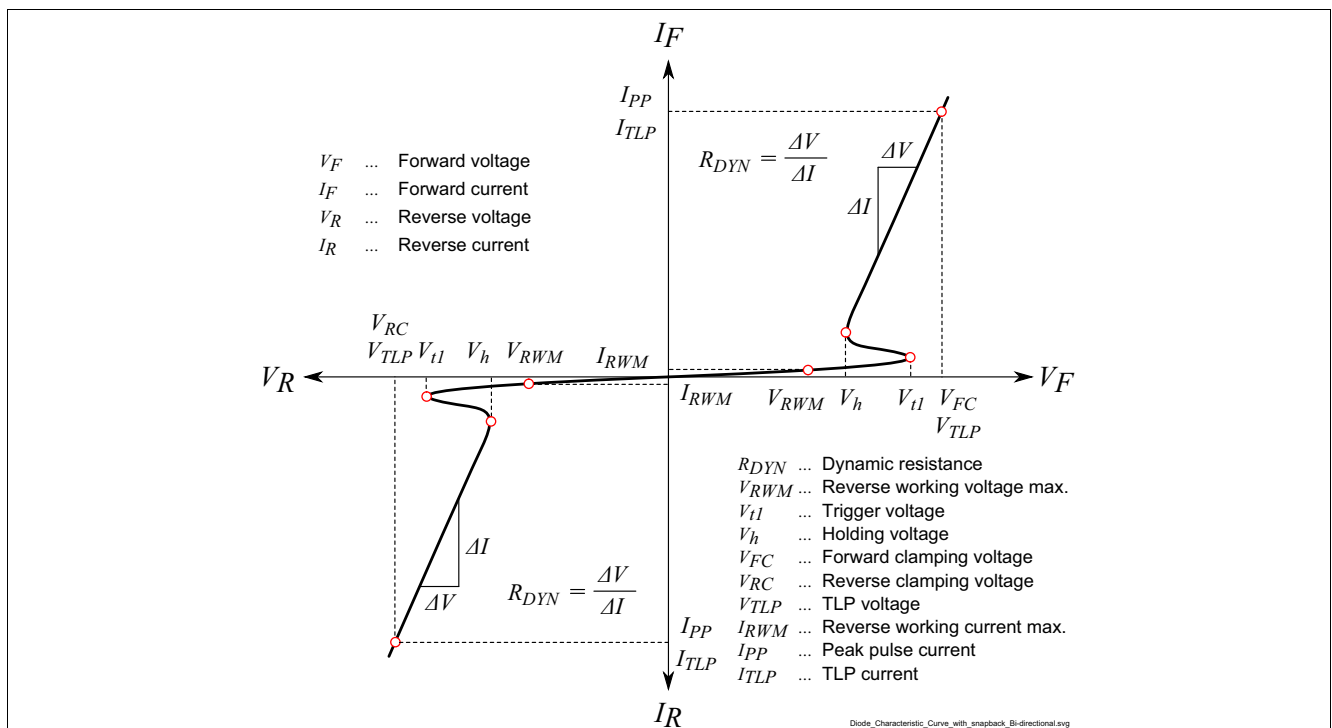
**Table 2** Maximum Ratings at  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified <sup>1)</sup>

Parameter	Symbol	Values			Unit
		Min.	Typ.	Max.	
ESD <sup>2)</sup> air discharge contact discharge	$V_{ESD}$	–	–	30 25	kV
Peak pulse current ( $t_p = 8 / 20\ \mu\text{s}$ ) <sup>3)</sup>	$I_{PP}$	–	–	5	A
Peak pulse power <sup>3)</sup> $t_p = 8 / 20\ \mu\text{s}$	$P_{PK}$	–	–	70	W
Operating temperature	$T_{OP}$	-55	–	125	$^\circ\text{C}$
Storage temperature	$T_{stg}$	-65	–	150	$^\circ\text{C}$

- 1) Device is electrically symmetrical
- 2)  $V_{ESD}$  according to IEC61000-4-2
- 3)  $I_{PP}$  according to IEC61000-4-5

**Attention:** Stresses above the max. values listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the integrated circuit.

### 2.1 Electrical Characteristics at $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified



**Figure 2** Definitions of electrical characteristics

**Table 3 DC Characteristics at  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified <sup>1)</sup>**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Reverse working voltage	$V_{RWM}$	–	–	5.5	V	
Reverse current	$I_R$	–	<1	20	nA	$V_R = 5.5\text{ V}$
Trigger voltage	$V_{t1}$	6.1	–	–	V	
Holding voltage	$V_h$	6.1	8	–	V	$I_R = 1\text{ mA}$

1) Device is electrically symmetrical

**Table 4 AC Characteristics at  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Line capacitance	$C_L$	–	0.3	0.45	pF	$V_R = 0\text{ V}, f = 1\text{ MHz}$
		–	0.3	0.45		$V_R = 0\text{ V}, f = 1\text{ GHz}$

**Table 5 ESD and Surge Characteristics at  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified <sup>1)</sup>**

Parameter	Symbol	Values			Unit	Note / Test Condition
		Min.	Typ.	Max.		
Clamping voltage <sup>2)</sup>	$V_{CL}$	–	13	16	V	$I_{TLP} = 16\text{ A}, t_p = 100\text{ ns}$
		–	19	22		$I_{TLP} = 30\text{ A}, t_p = 100\text{ ns}$
Clamping voltage <sup>3)</sup>		–	8.5	11.5		$I_{PP} = 2\text{ A}, t_p = 8/20\text{ }\mu\text{s}$
		–	11	14		$I_{PP} = 5\text{ A}, t_p = 8/20\text{ }\mu\text{s}$
Dynamic resistance <sup>2)</sup>	$R_{DYN}$	–	0.36	0.45	$\Omega$	$t_p = 100\text{ ns}$

1) Device is electrically symmetrical

2) Please refer to Application Note AN210 [1]. TLP parameter:  $Z_0 = 50\text{ }\Omega$ ,  $t_p = 100\text{ ns}$ ,  $t_r = 300\text{ ps}$ , averaging window:  $t_1 = 30\text{ ns}$  to  $t_2 = 60\text{ ns}$ , extraction of dynamic resistance using least squares fit of TLP characteristics between  $I_{TLP1} = 10\text{ A}$  and  $I_{TLP2} = 50\text{ A}$ .

3)  $I_{PP}$  according to IEC61000-4-5 ( $t_p = 8/20\text{ }\mu\text{s}$ )

Typical Characteristics at  $T_A = 25\text{ °C}$ , unless otherwise specified

### 3 Typical Characteristics at $T_A = 25\text{ °C}$ , unless otherwise specified

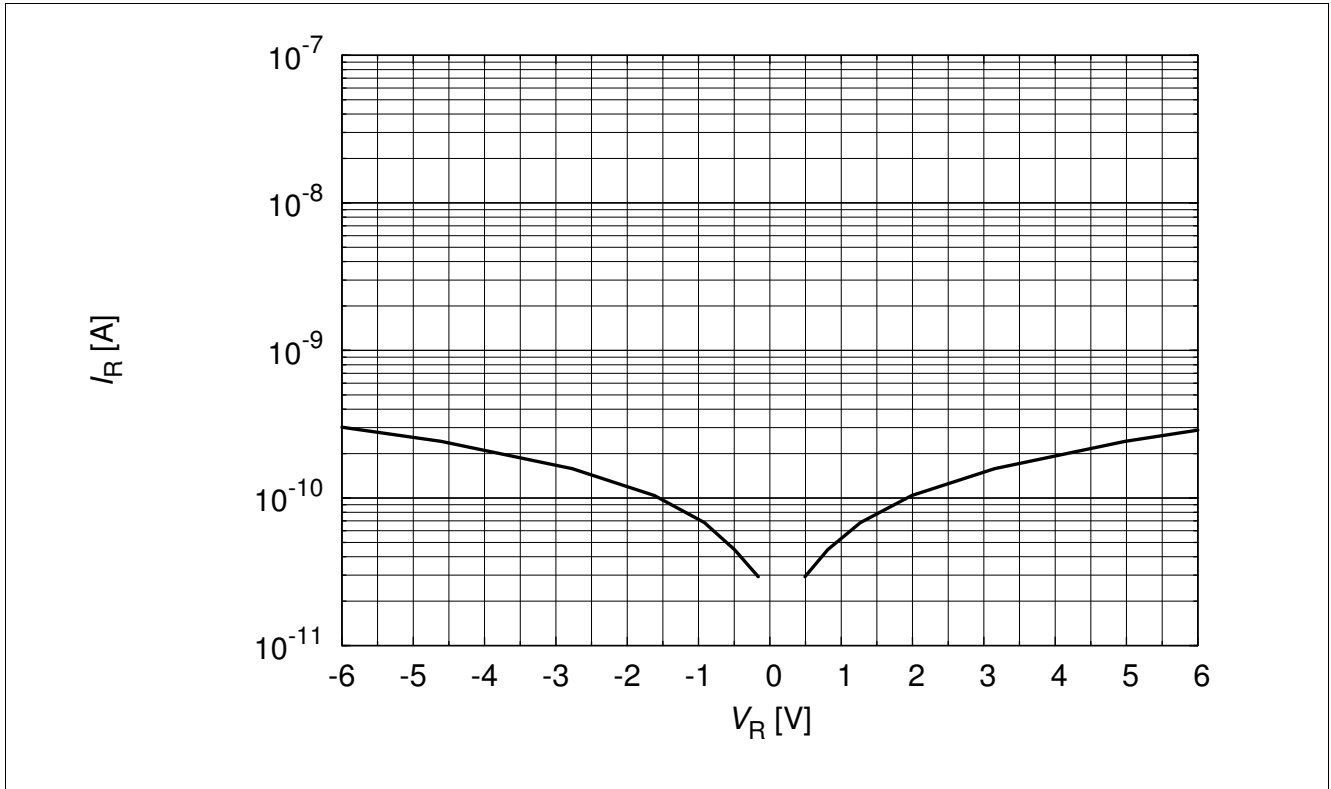


Figure 3 Reverse current:  $I_R = f(V_R)$

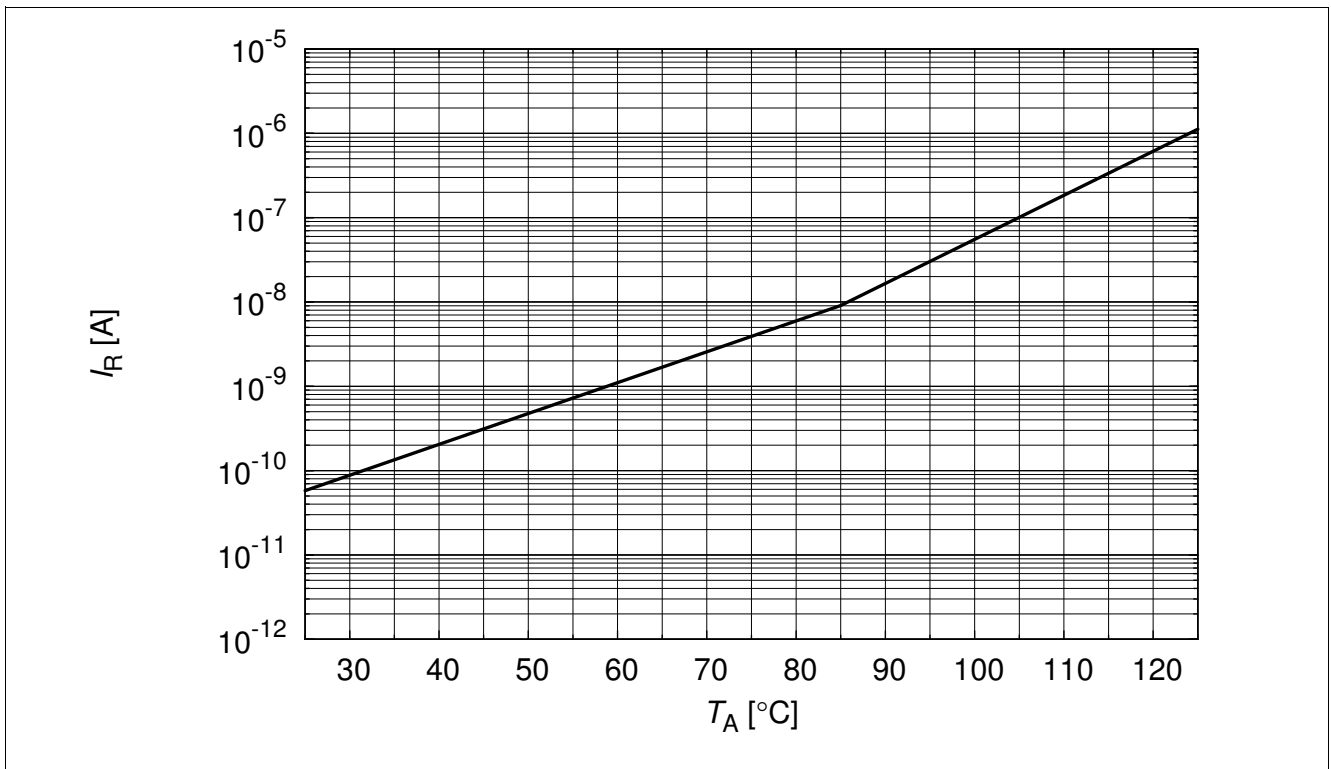


Figure 4 Reverse current:  $I_R = f(T_A)$ ,  $V_R = 5.5\text{ V}$

Typical Characteristics at  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified

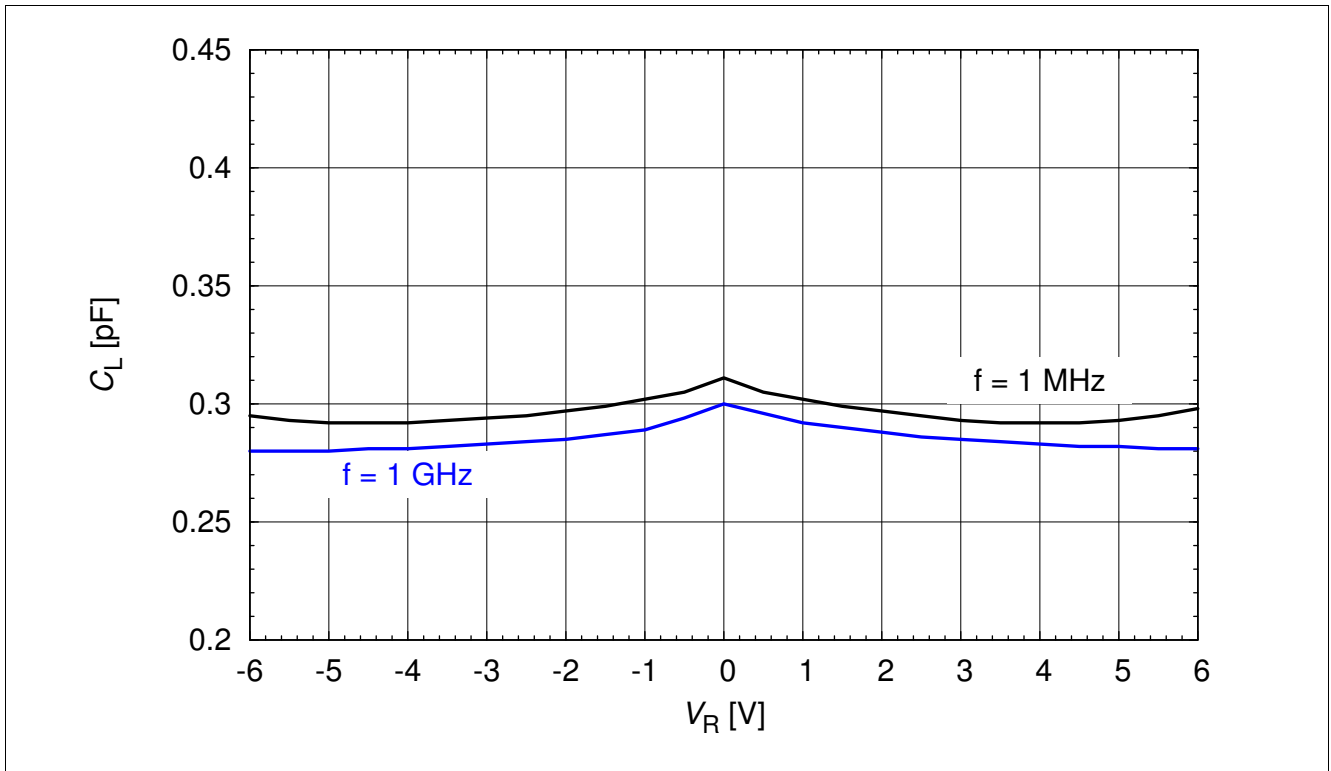


Figure 5 Line capacitance:  $C_L = f(V_R), f = 1\text{ MHz}$

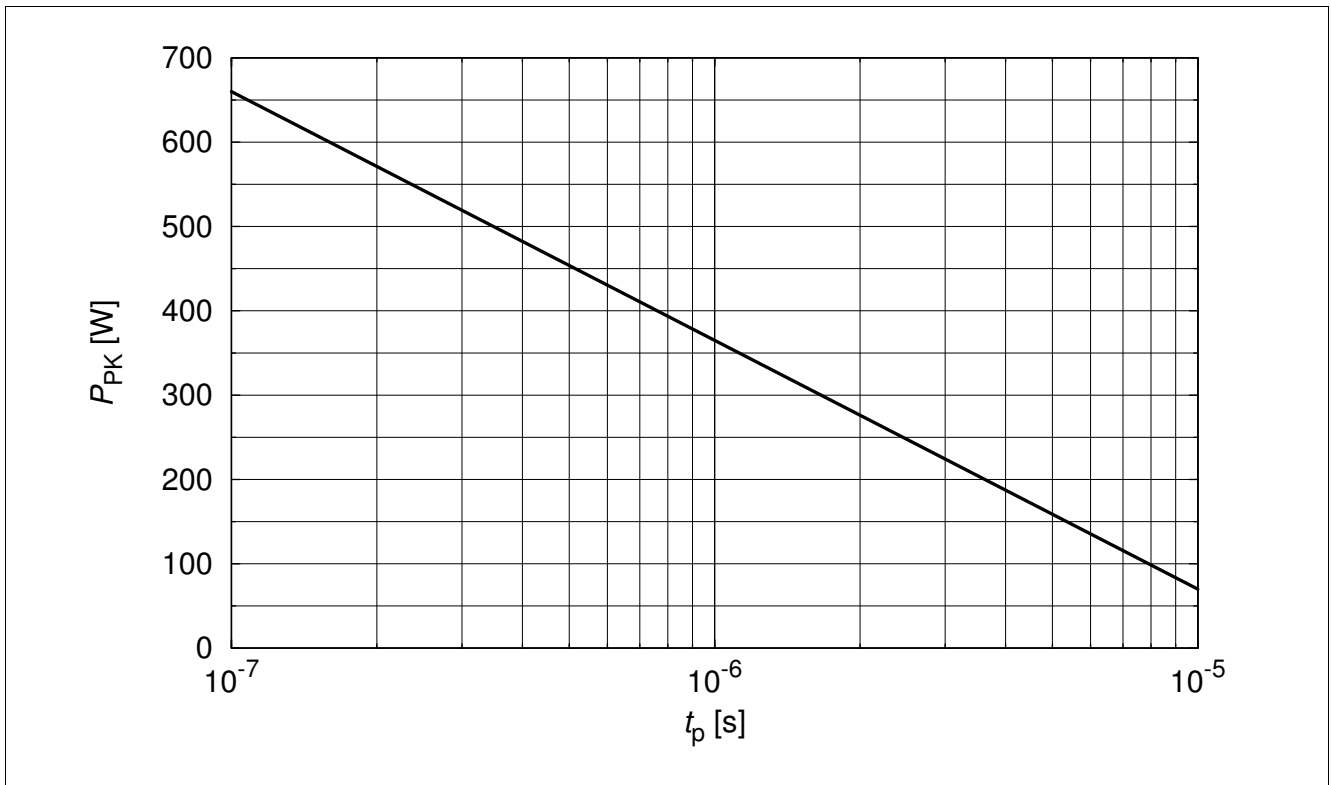
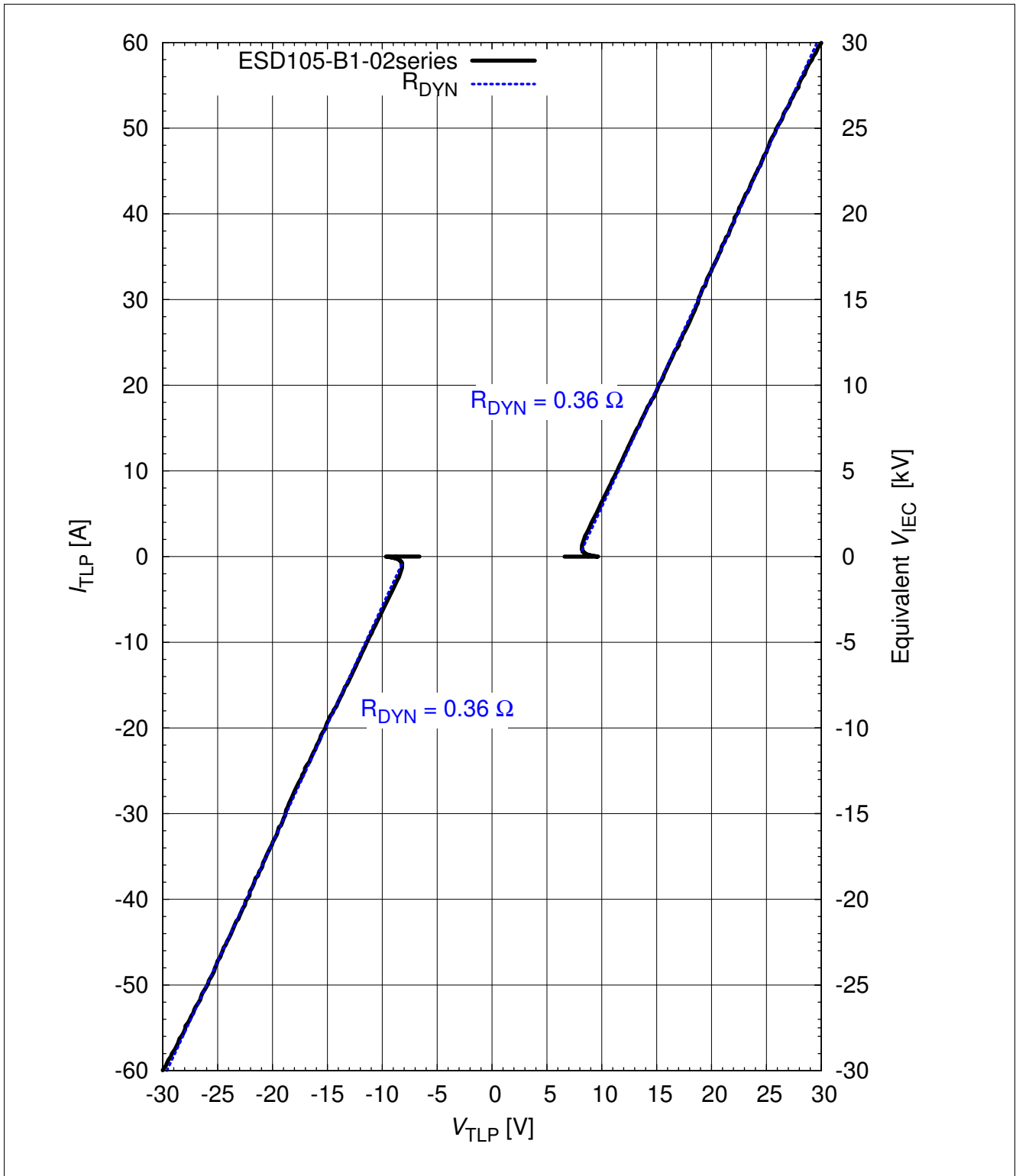


Figure 6 Peak pulse power:  $P_{PK} = f(t_p)$

Typical Characteristics at  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified



**Figure 7** Clamping voltage (TLP):  $I_{TLP} = f(V_{TLP})$  according ANSI/ESD STM5.5.1 - Electrostatic Discharge Sensitivity Testing using Transmission Line Pulse (TLP) Model. TLP conditions:  $Z_0 = 50\ \Omega$ ,  $t_p = 100\text{ ns}$ ,  $t_r = 0.6\text{ ns}$ ,  $I_{TLP}$  and  $V_{TLP}$  averaging window:  $t_1 = \text{ns}$  to  $t_2 = 60\text{ ns}$ , extraction of dynamic resistance using squares fit to TLP characteristics between  $I_{TLP1} = 10\text{ A}$  and  $I_{TLP2} = 50\text{ A}$ . Please refer to Application Note AN210[1]

Typical Characteristics at  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified

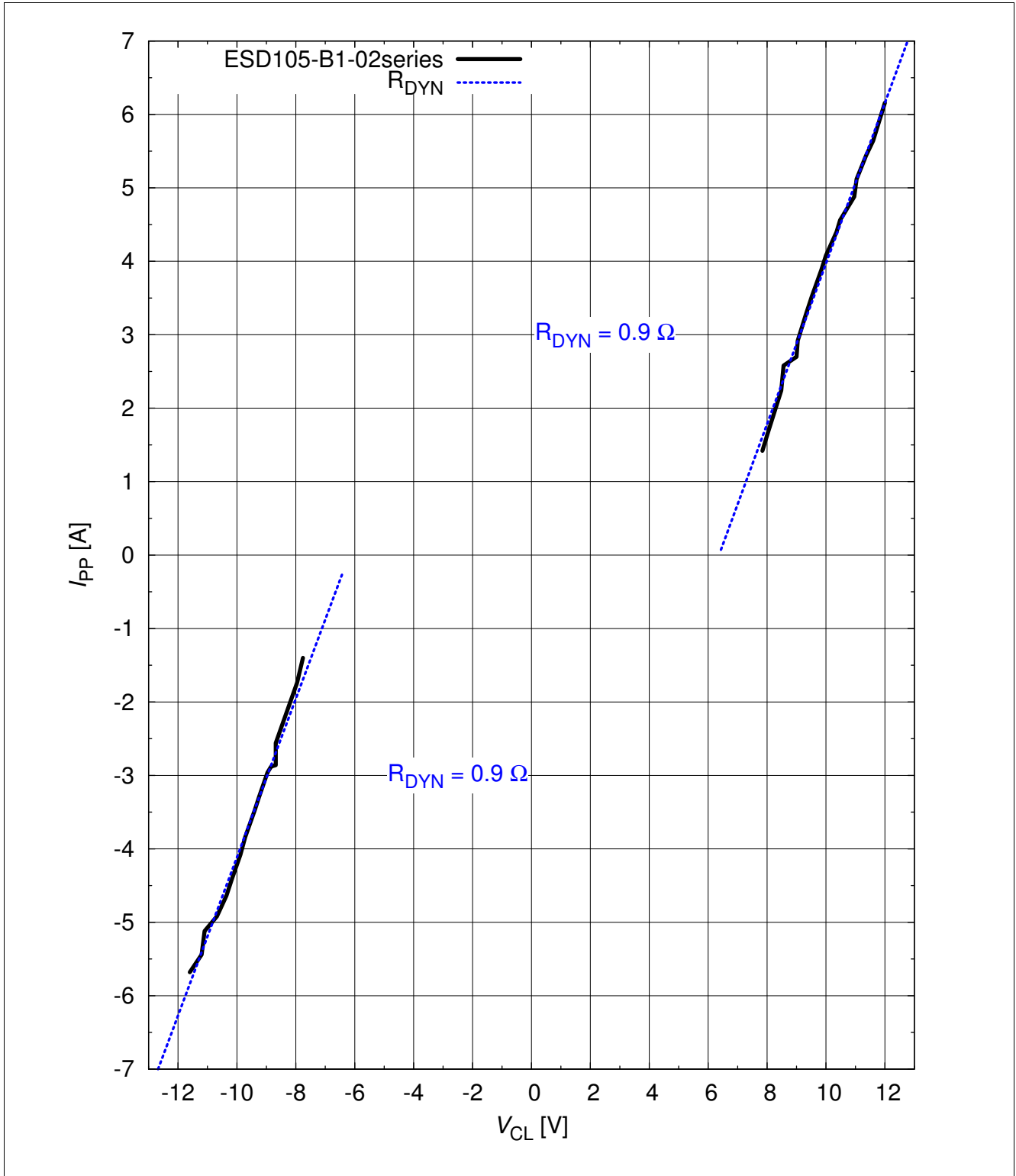


Figure 8 Pulse current (IEC61000-4-5) versus clamping voltage:  $I_{PP} = f(V_{CL})$

Typical Characteristics at  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified

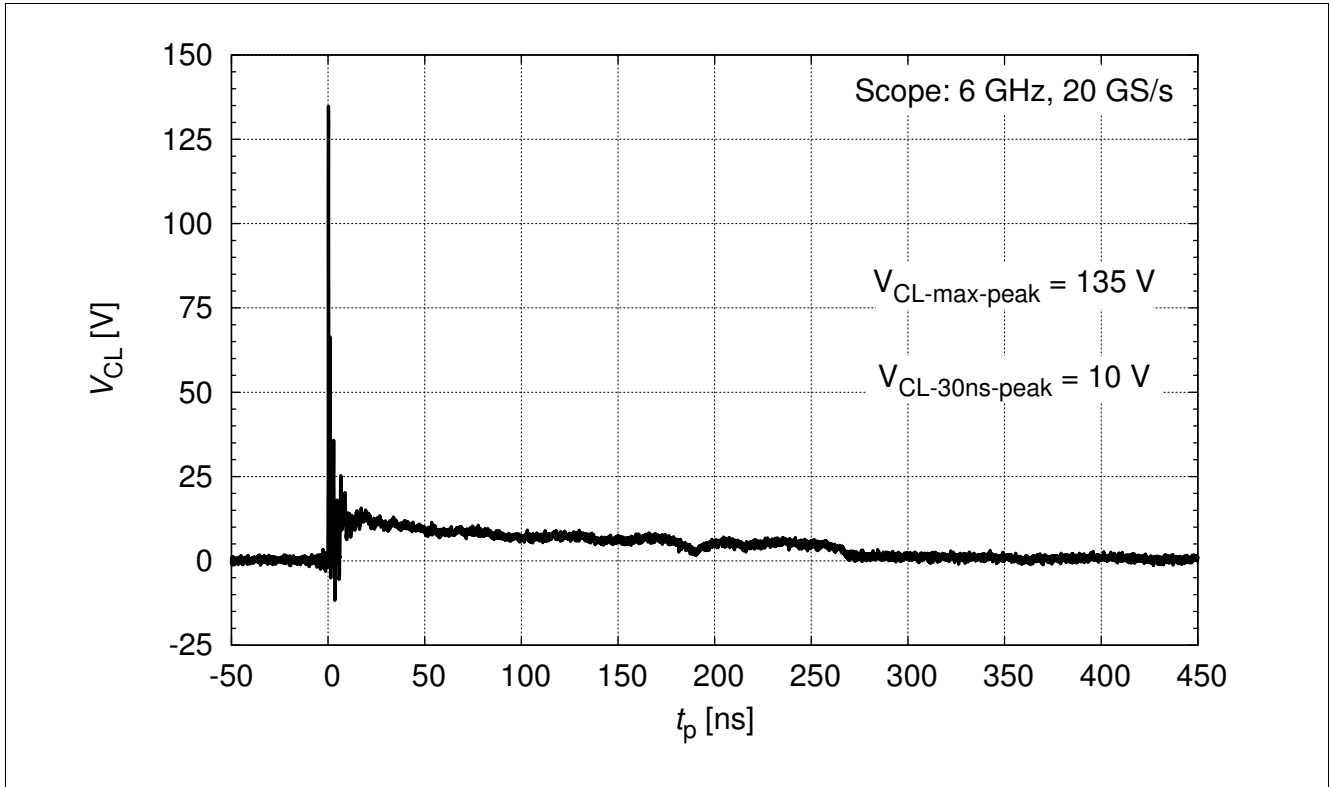


Figure 9 IEC61000-4-2:  $V_{CL} = f(t)$ , 8 kV positive pulse from pin 1 to pin 2

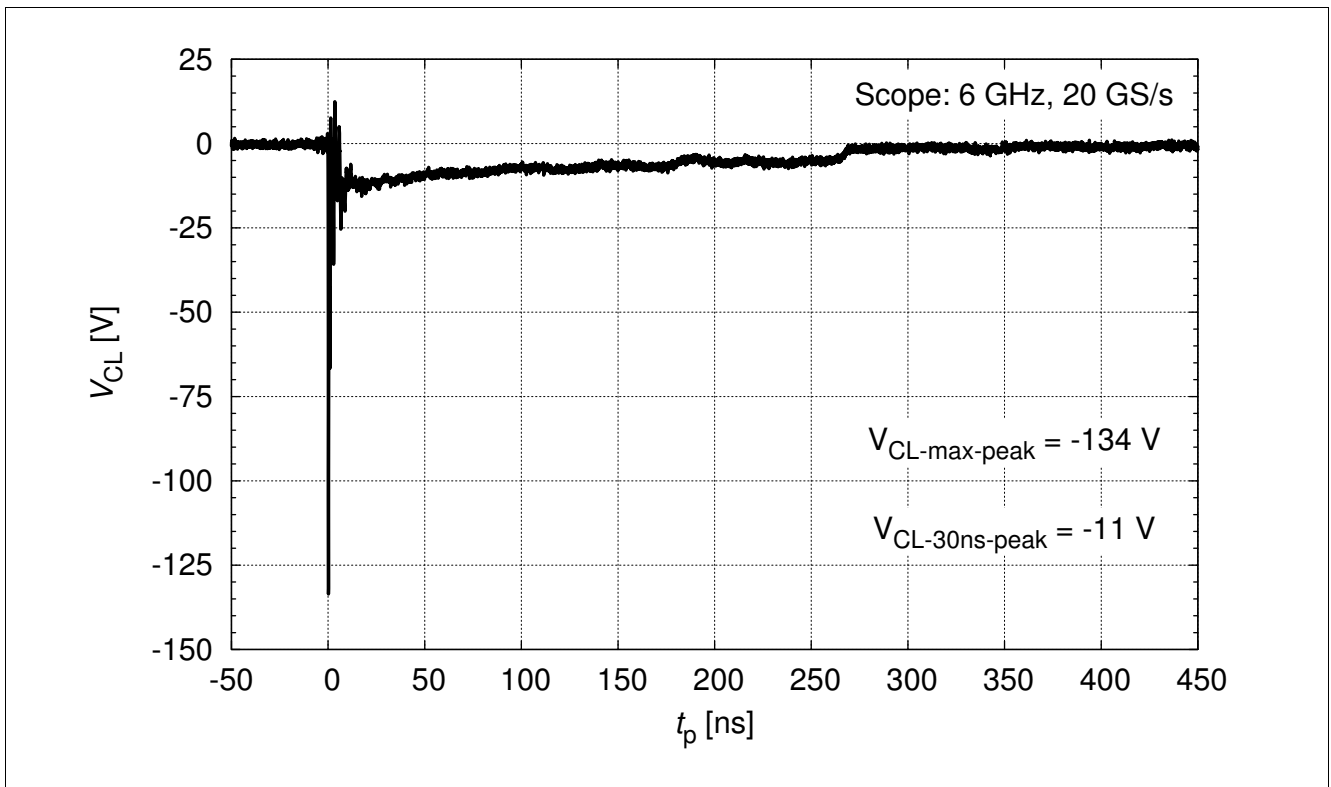


Figure 10 IEC61000-4-2:  $V_{CL} = f(t)$ , 8 kV negative pulse from pin 1 to pin 2

Typical Characteristics at  $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise specified

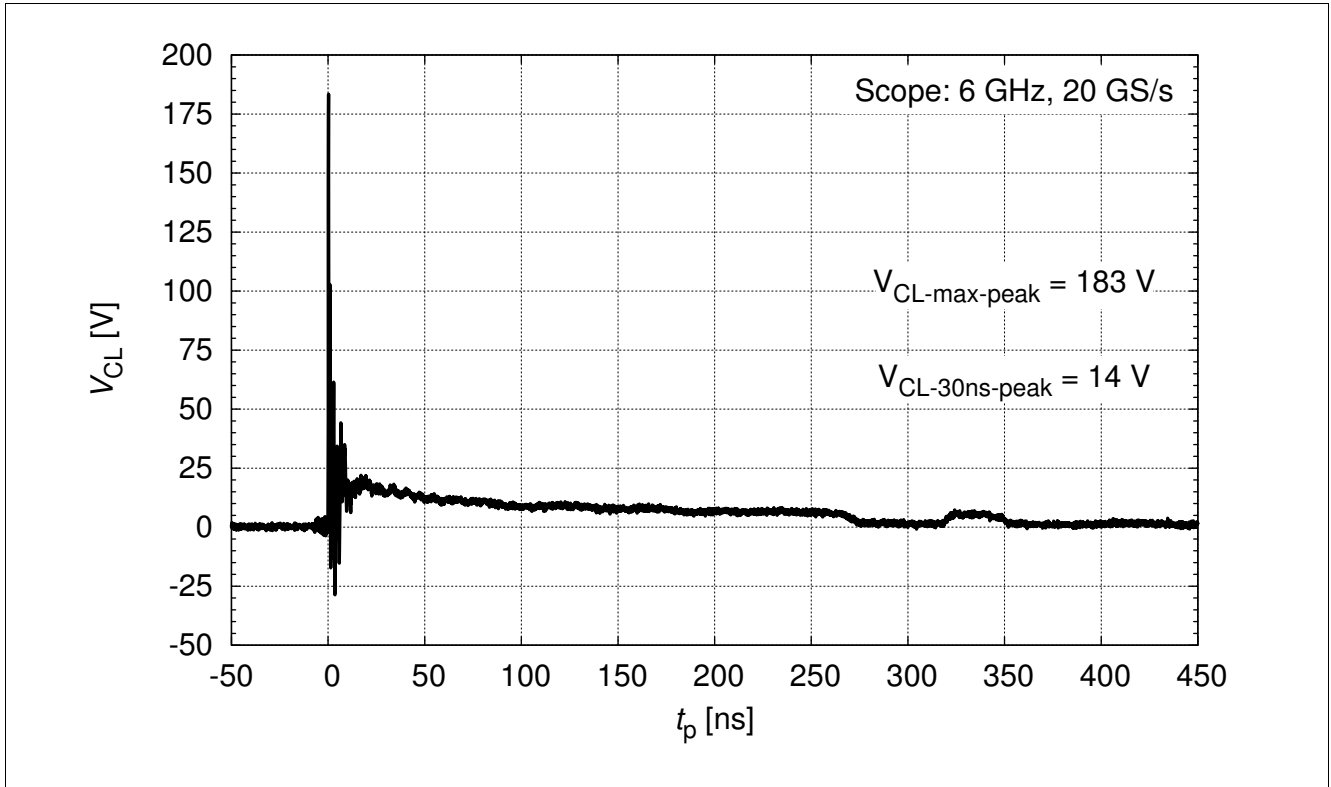


Figure 11 IEC61000-4-2:  $V_{CL} = f(t)$ , 15 kV positive pulse from pin 1 to pin 2

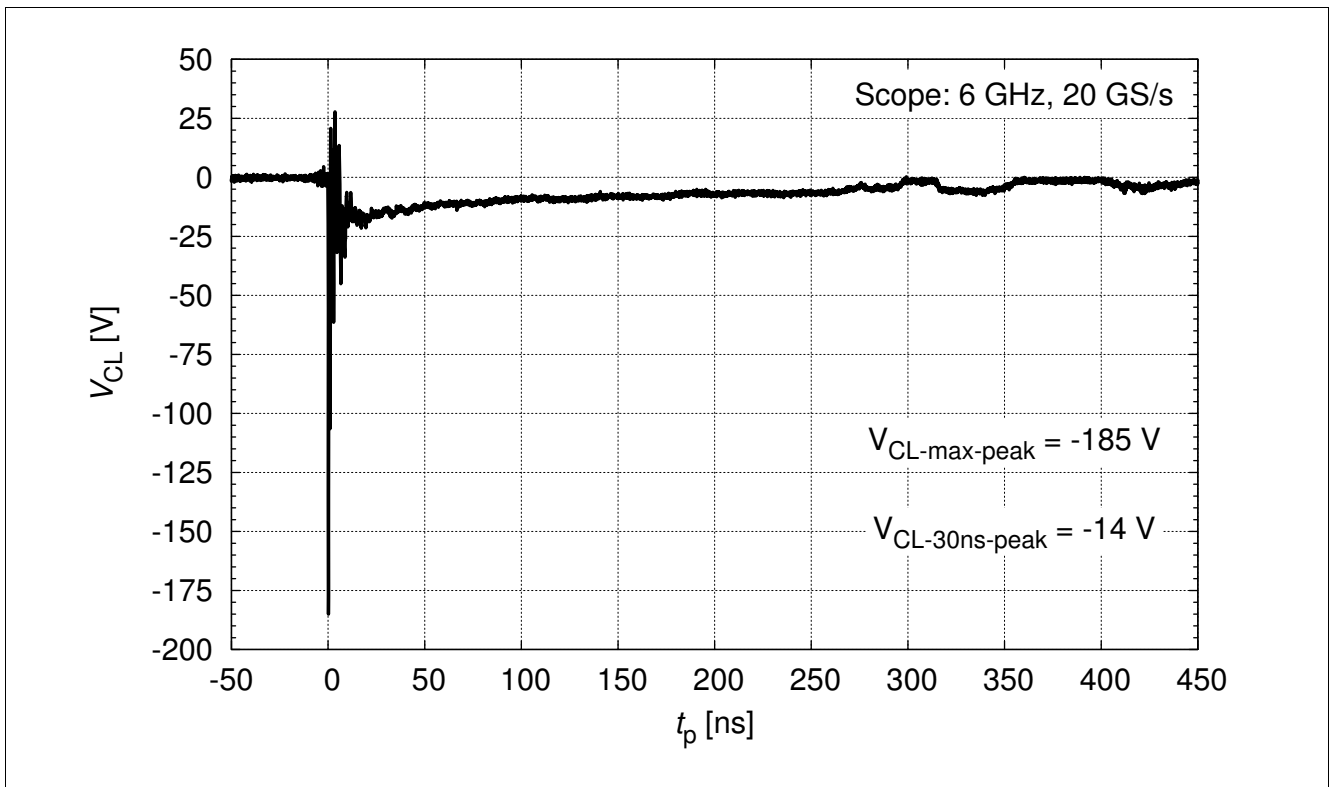


Figure 12 IEC61000-4-2:  $V_{CL} = f(t)$ , 15 kV negative pulse from pin 1 to pin 2

## 4 Application Information

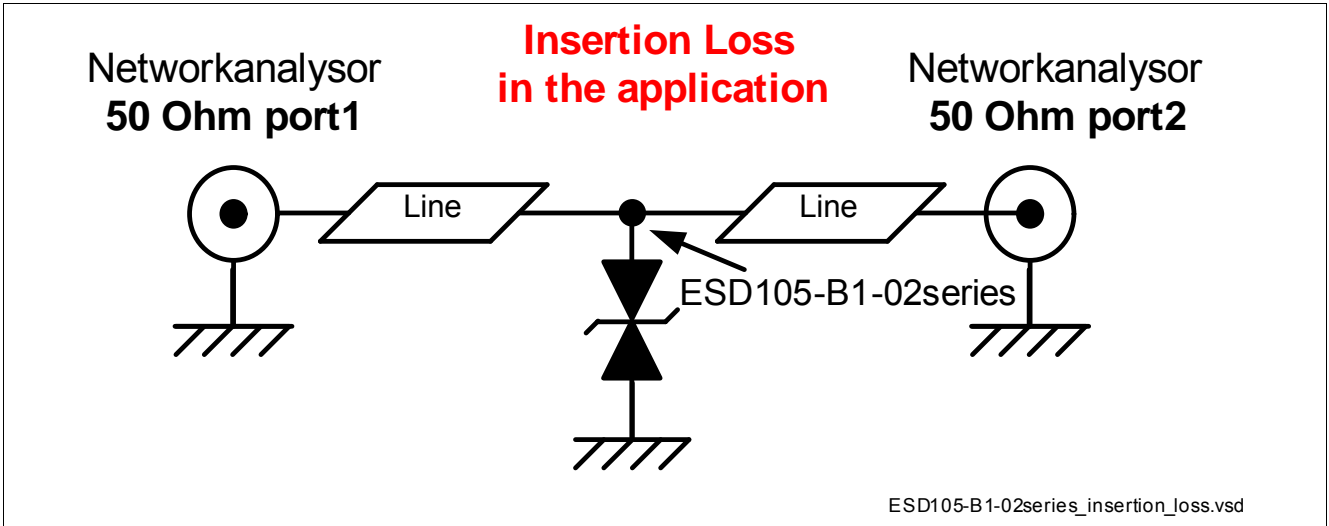


Figure 13 Insertion loss measured in 50 Ω environment

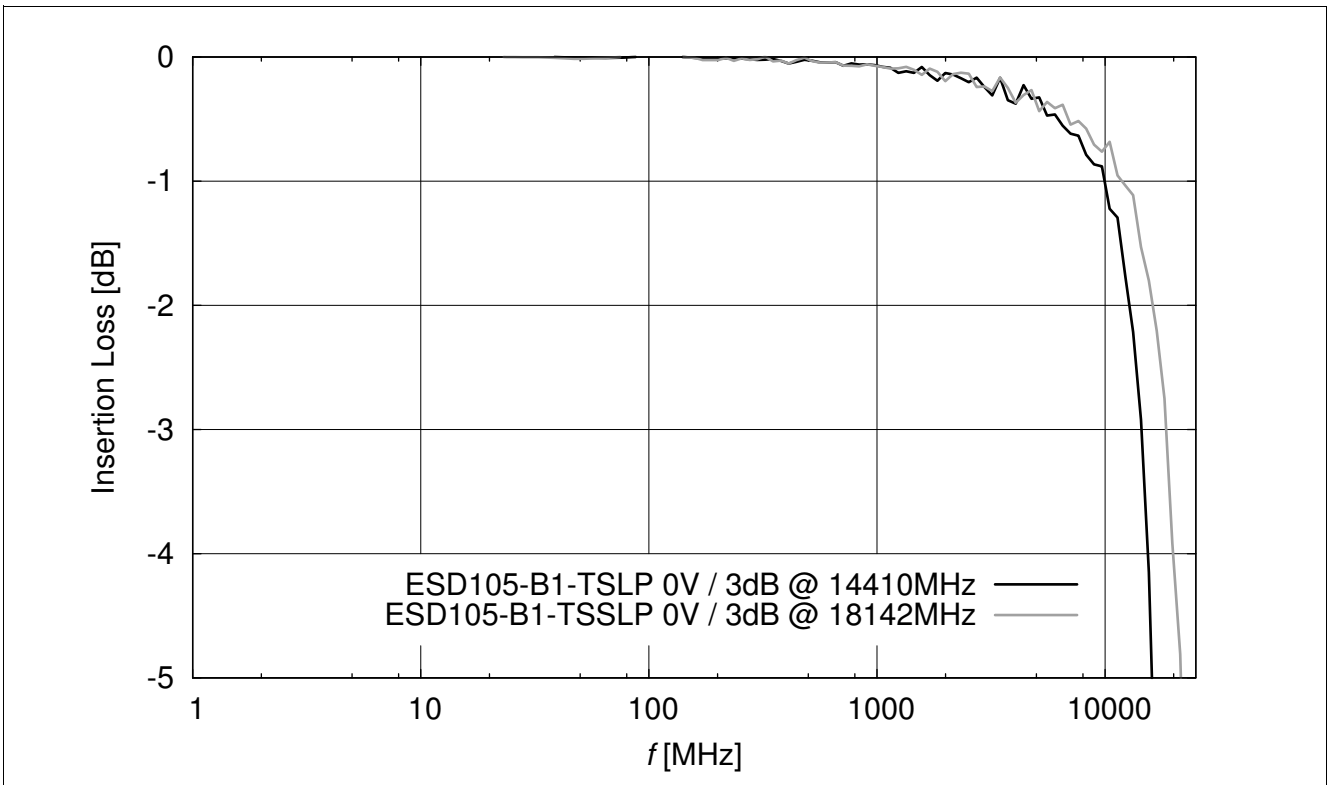


Figure 14 Insertion loss vs. frequency of ESD105-B1-02xx in a 50 Ω system

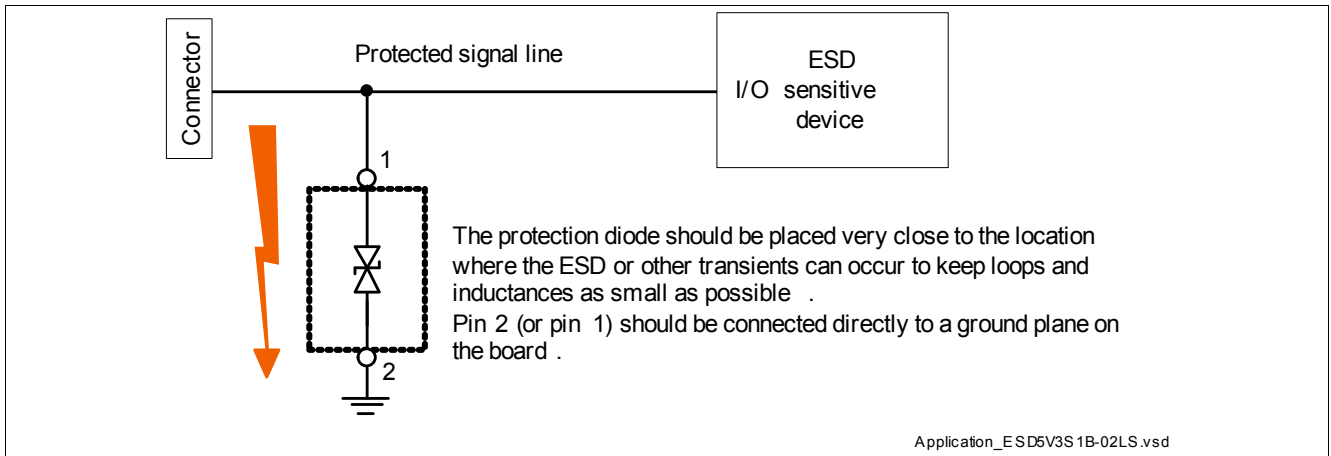


Figure 15 Single line, bi-directional ESD / Transient protection

## 5 Package Information

### 5.1 TSSLP-2-4

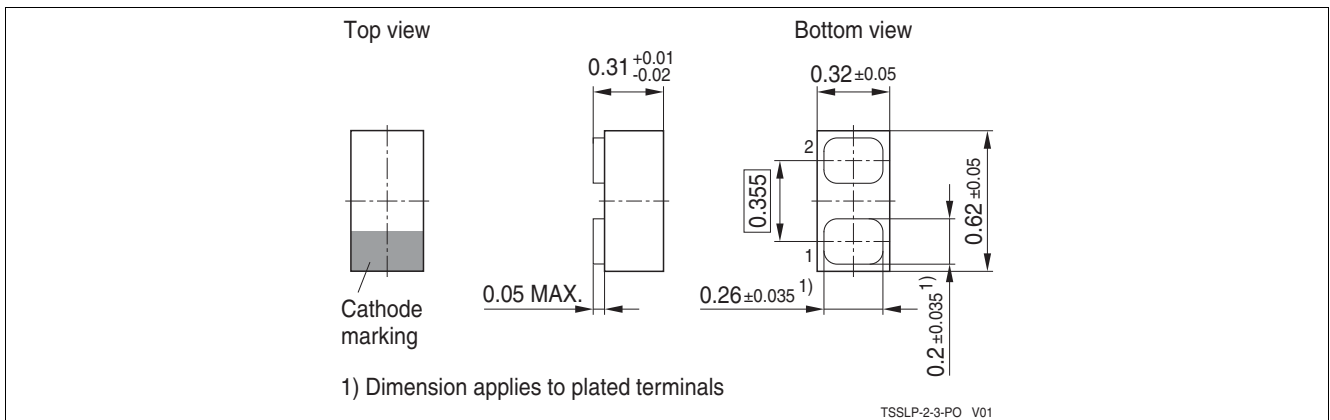


Figure 16 TSSLP-2-4 Package outline

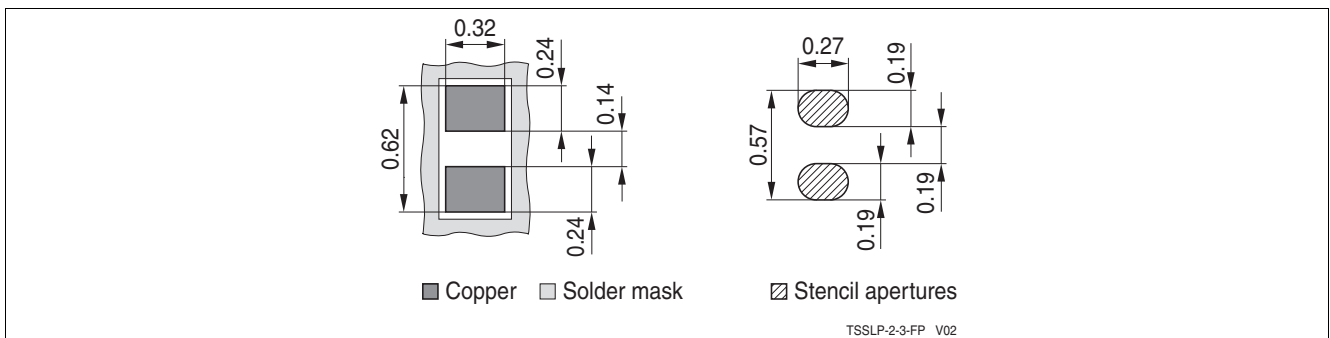


Figure 17 TSSLP-2-4 Footprint

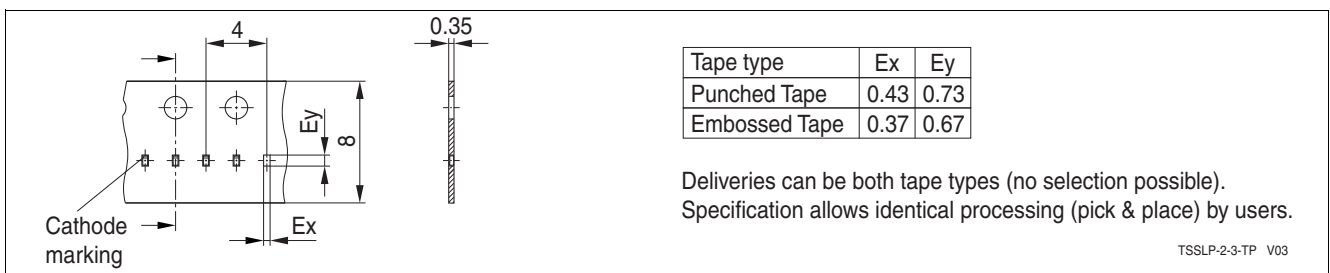


Figure 18 TSSLP-2-4 Packing

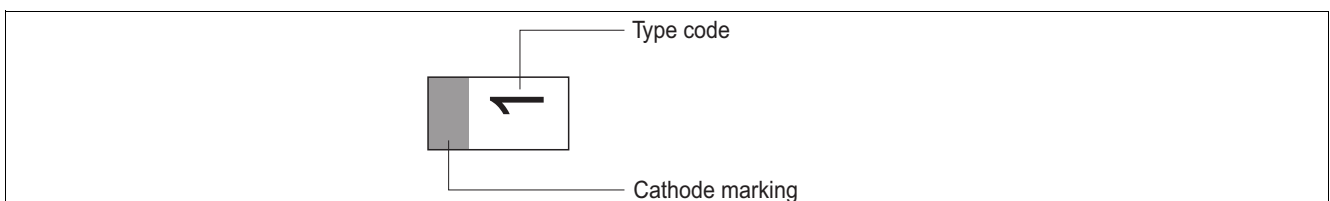


Figure 19 TSSLP-2-4 Marking (example)

5.2 TSLP-2-20

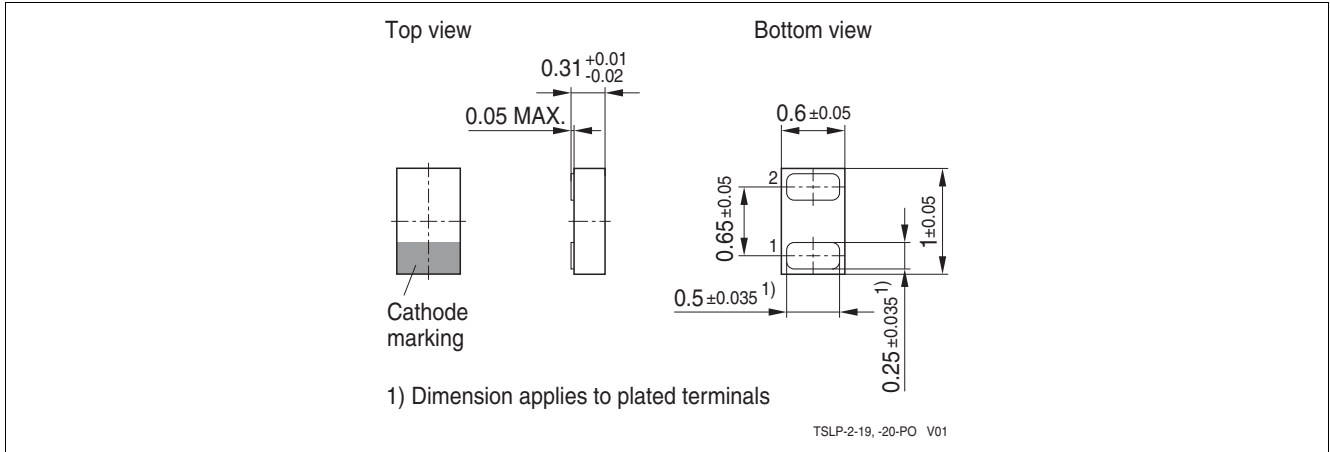


Figure 20 TSLP-2-20 Package outline

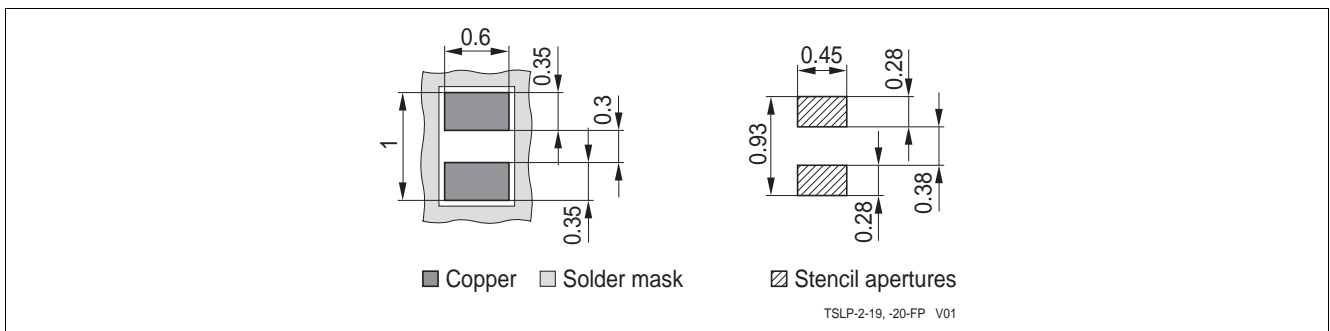


Figure 21 TSLP-2-20 Footprint

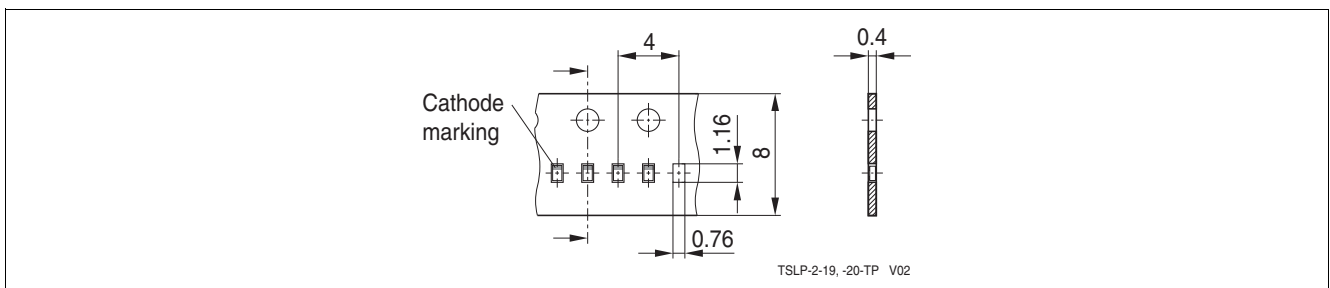


Figure 22 TSLP-2-20 Packing

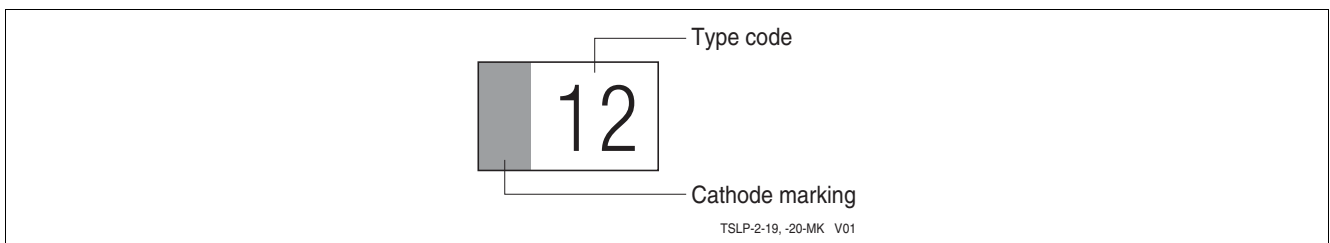


Figure 23 TSLP-2-20 Marking (example)

**References**

- [1] Infineon Technologies AG, "Effective ESD Protection Design at System Level Using VF-TLP Characterization Methodology", Application Note 210, RF and Protection Devices, April 22, 2010, Rev.1.0
- [2] Infineon AG - Recommendations for PCB Assembly of Infineon TSLP and TSSLP Packages

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